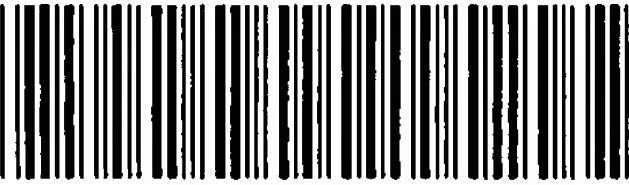


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/044,945	IWAMURA ET AL.	
	Examiner	Art Unit	
	Jason E. Mattis	2616	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Discussed Applicant's arguments and search with SPE Huy Vu	11/6/2007	JM
Repeated text search of previous areas	11/6/2007	JM